

Application/Control No.	Applicant(s)/Patent under Reexamination
10/829,172	TERAO, KENJI
Examiner	Art Unit

2611

Dac V. Ha

	SEARCHED				
Class	Subclass	Date	Examiner		
375	267, 345	6/18/2007	DH 1		
	347				
455	67.11				
	133-136				
	232.1				
	233.1				
	234.1				
	240.1				
	245.1				
	277.1				
	277.2				

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEA (INCLUDING S	RCH NOT SEARCH S	ES STRATEGY)
		DATE	EXMR
BRS		6/18/2007	DH
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